Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/664,185	RHEE ET AL.	
Examiner	Art Unit	
Joseph D. Pape	3612	

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Class	Subclass	Date	Examiner
Updated	Previous search	4/22/2006	JDP

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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